

STARPOWER

SEMICONDUCTOR

SiC MOSFET

MD24HTL120P12HLT

1200V/2.40mΩ 6 in one-package

General Description

STARPOWER MOSFET Power Module provides very low $R_{DS(on)}$ as well as optimized intrinsic diode. It's designed for the applications such as hybrid and electric vehicle.

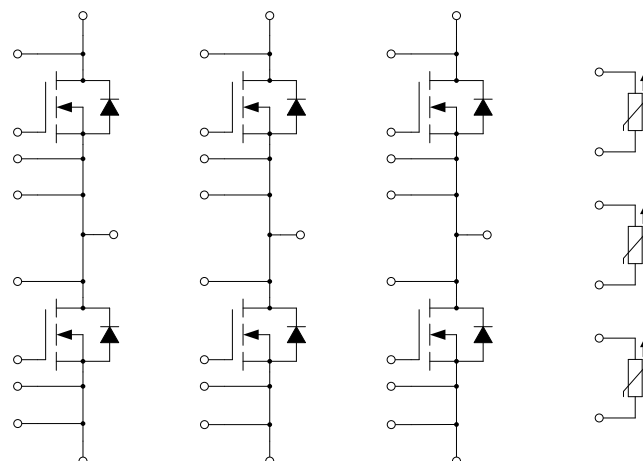
Features

- SiC power MOSFET
- High blocking voltage with low $R_{DS(on)}$
- Easy to parallel and simple to drive
- Low inductance case avoid oscillations
- Isolated copper pinfin baseplate using Si_3N_4 AMB technology

Typical Applications

- Automotive application
- Hybrid and electric vehicle
- Inverter for motor drive

Equivalent Circuit Schematic



Absolute Maximum Ratings $T_F=25^{\circ}\text{C}$ unless otherwise noted**MOSFET**

Symbol	Description	Value	Unit
V_{DSS}	Drain-Source Voltage	1200	V
V_{GSSmax}	Gate-Source Voltage	-8/+19	V
V_{GSSop}	Gate-Source Voltage	-4/+15	V
I_D	Drain Current @ $T_F=75^{\circ}\text{C}$ $T_{vj}=175^{\circ}\text{C}$	430	A
I_{DRM}	Repetitive Peak Drain Current $t_p=1\text{ms}$	860	A
P_D	Maximum Power Dissipation @ $T_F=75^{\circ}\text{C}$ $T_{vj}=175^{\circ}\text{C}$	850	W

Body Diode

Symbol	Description	Value	Unit
I_S	Source Current @ $T_F=75^{\circ}\text{C}$ $T_{vj}=175^{\circ}\text{C}$	212	A

Module

Symbol	Description	Value	Unit
T_{vjmax}	Maximum Junction Temperature	185	$^{\circ}\text{C}$
T_{vjop}	Operating Junction Temperature continuous For 10s within a period of 30s,occurrence maximum 3000 times over lifetime	-40 to +185 +185 to +200	$^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-40 to +125	$^{\circ}\text{C}$
V_{ISO}	Isolation Voltage RMS, $f=50\text{Hz}$, $t=1\text{min}$	3000	V

MOSFET Characteristics $T_F=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$R_{DS(on)}$	Static Drain-Source On-Resistance	$I_D=380\text{A}, V_{GS}=15\text{V}, T_{vj}=25^{\circ}\text{C}$		2.40		m Ω
		$I_D=380\text{A}, V_{GS}=15\text{V}, T_{vj}=150^{\circ}\text{C}$		3.56		
		$I_D=380\text{A}, V_{GS}=15\text{V}, T_{vj}=175^{\circ}\text{C}$		3.84		
$V_{GS(th)}$	Gate-Source Threshold Voltage	$I_D=100\text{mA}, V_{DS}=V_{GS}, T_{vj}=25^{\circ}\text{C}$	1.8	2.5	3.2	V
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=V_{DSS}, V_{GS}=0\text{V}, T_{vj}=25^{\circ}\text{C}$			1.0	mA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=V_{GSS}, V_{DS}=0\text{V}, T_{vj}=25^{\circ}\text{C}$			400	nA
R_{Gint}	Internal Gate Resistance			1.8		Ω
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=800\text{V}, f=100\text{kHz}$		34.2		nF
C_{oss}	Output Capacitance			1.24		nF
C_{rss}	Reverse Transfer Capacitance			41.7		pF
Q_g	Total Gate Charge	$I_D=380\text{A}, V_{DS}=800\text{V}, V_{GS}=-4/+15\text{V}$		1.07		μC
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=800\text{V}, I_D=400\text{A}, R_{Gon}=5.6\Omega, R_{Goff}=3.3\Omega, L_S=7\text{nH}, V_{GS}=-4/+15\text{V}, T_{vj}=25^{\circ}\text{C}$		160		ns
t_r	Rise Time			75		ns
$t_{d(off)}$	Turn-Off Delay Time			275		ns
t_f	Fall Time			43		ns
E_{on}	Turn-On Switching Loss			24.3		mJ
E_{off}	Turn-Off Switching Loss			14.3		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=800\text{V}, I_D=400\text{A}, R_{Gon}=5.6\Omega, R_{Goff}=3.3\Omega, L_S=7\text{nH}, V_{GS}=-4/+15\text{V}, T_{vj}=150^{\circ}\text{C}$		163		ns
t_r	Rise Time			77		ns
$t_{d(off)}$	Turn-Off Delay Time			392		ns
t_f	Fall Time			44		ns
E_{on}	Turn-On Switching Loss			24.5		mJ
E_{off}	Turn-Off Switching Loss			17.0		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=800\text{V}, I_D=400\text{A}, R_{Gon}=5.6\Omega, R_{Goff}=3.3\Omega, L_S=7\text{nH}, V_{GS}=-4/+15\text{V}, T_{vj}=175^{\circ}\text{C}$		165		ns
t_r	Rise Time			78		ns
$t_{d(off)}$	Turn-Off Delay Time			416		ns
t_f	Fall Time			45		ns
E_{on}	Turn-On Switching Loss			24.9		mJ
E_{off}	Turn-Off Switching Loss			17.5		mJ

Body Diode Characteristics $T_F=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_{SD}	Diode Forward Voltage	$I_{SD}=193\text{A}, V_{GS}=-4\text{V}, T_{vj}=25^{\circ}\text{C}$		4.25		V
		$I_{SD}=193\text{A}, V_{GS}=-4\text{V}, T_{vj}=150^{\circ}\text{C}$		3.80		
		$I_{SD}=193\text{A}, V_{GS}=-4\text{V}, T_{vj}=175^{\circ}\text{C}$		3.75		
t_{rr}	Diode Reverse Recovery Time	$V_R=800\text{V}, I_S=400\text{A}, -di/dt=5540\text{A}/\mu\text{s}, L_S=7\text{nH}, V_{GS}=-4\text{V}, T_{vj}=25^{\circ}\text{C}$		31		ns
Q_r	Recovered Charge			1.07		μC
I_{RM}	Peak Reverse Recovery Current			62		A
E_{rec}	Reverse Recovery Energy			0.15		mJ
t_{rr}	Diode Reverse Recovery Time	$V_R=800\text{V}, I_S=400\text{A}, -di/dt=5950\text{A}/\mu\text{s}, L_S=7\text{nH}, V_{GS}=-4\text{V}, T_{vj}=150^{\circ}\text{C}$		44		ns
Q_r	Recovered Charge			3.10		μC
I_{RM}	Peak Reverse Recovery Current			114		A
E_{rec}	Reverse Recovery Energy			0.55		mJ
t_{rr}	Diode Reverse Recovery Time	$V_R=800\text{V}, I_S=400\text{A}, -di/dt=6250\text{A}/\mu\text{s}, L_S=7\text{nH}, V_{GS}=-4\text{V}, T_{vj}=175^{\circ}\text{C}$		49		ns
Q_r	Recovered Charge			4.09		μC
I_{RM}	Peak Reverse Recovery Current			138		A
E_{rec}	Reverse Recovery Energy			0.78		mJ

NTC Characteristics $T_{vj}=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R_{25}	Rated Resistance			5.0		$\text{k}\Omega$
$\Delta R/R$	Deviation of R_{100}	$T_C=100^{\circ}\text{C}, R_{100}=493.3\Omega$	-5		5	%
P_{25}	Power Dissipation				20.0	mW
$B_{25/50}$	B-value	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15\text{K}))]$		3375		K
$B_{25/80}$	B-value	$R_2=R_{25}\exp[B_{25/80}(1/T_2-1/(298.15\text{K}))]$		3411		K
$B_{25/100}$	B-value	$R_2=R_{25}\exp[B_{25/100}(1/T_2-1/(298.15\text{K}))]$		3433		K

Module Characteristics $T_F=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
L_{CE}	Stray Inductance		8		nH
$R_{CC'+EE'}$	Module Lead Resistance, Terminal to Chip		0.43		m Ω
p	Maximum Pressure In Cooling Circuit			2.5	bar
R_{thJF}	Junction-to-Cooling Fluid (per MOSFET) $\Delta V/\Delta t=10.0\text{dm}^3/\text{min}, T_F=75^{\circ}\text{C}$		0.107	0.123	K/W
M	Terminal Connection Torque, Screw M5 Mounting Torque, Screw M4	3.6 1.8		4.4 2.2	N.m
G	Weight of Module		792		g

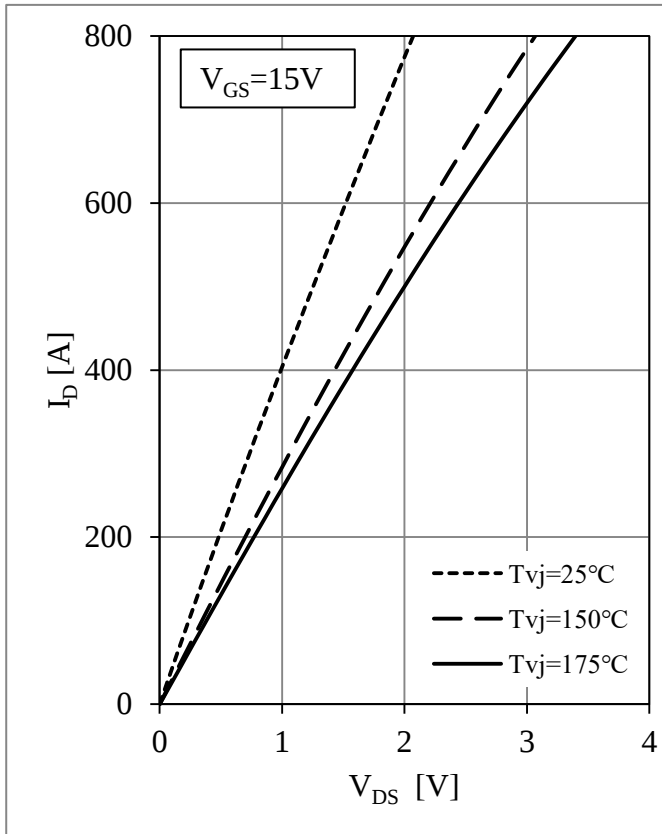


Fig 1. MOSFET Output Characteristics

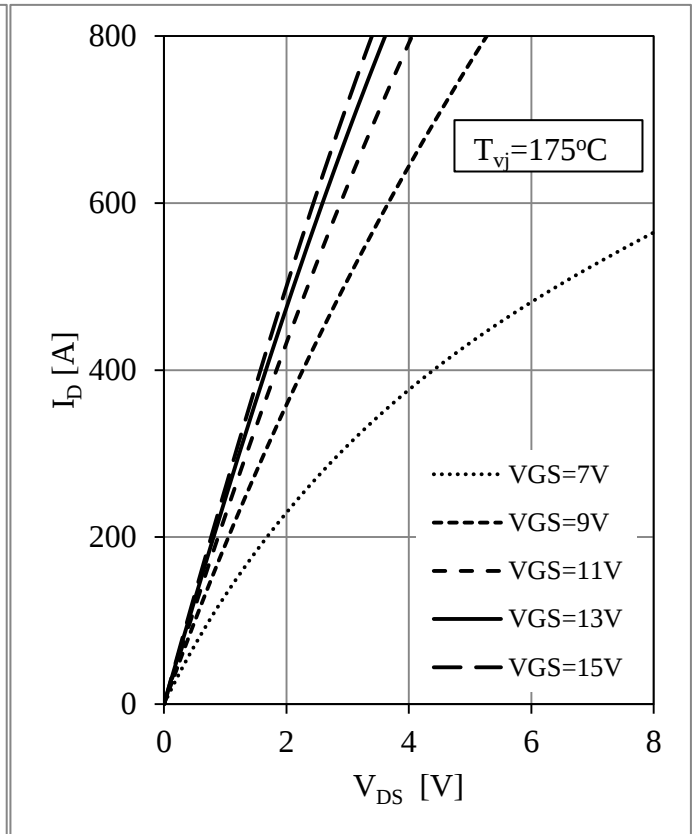


Fig 2. MOSFET Output Characteristics

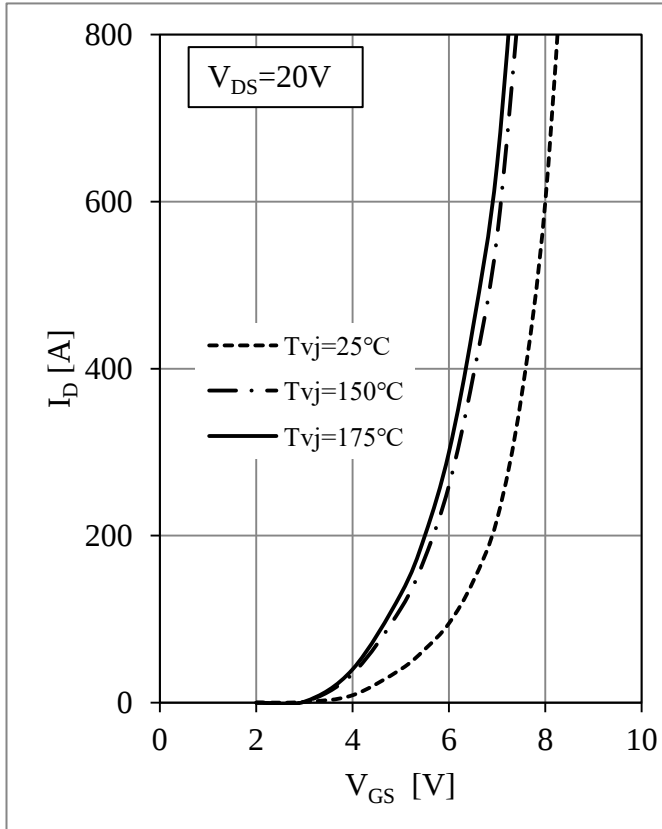
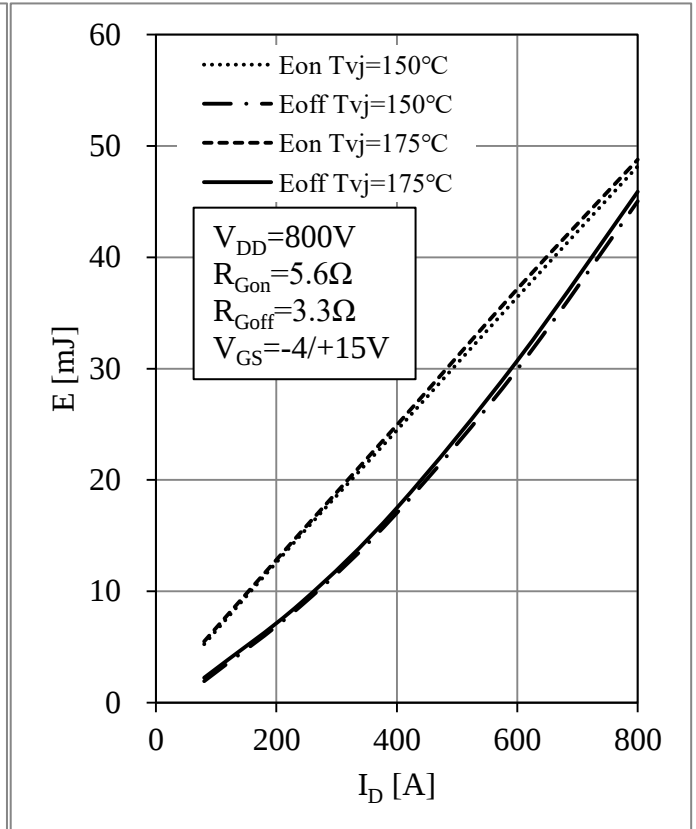
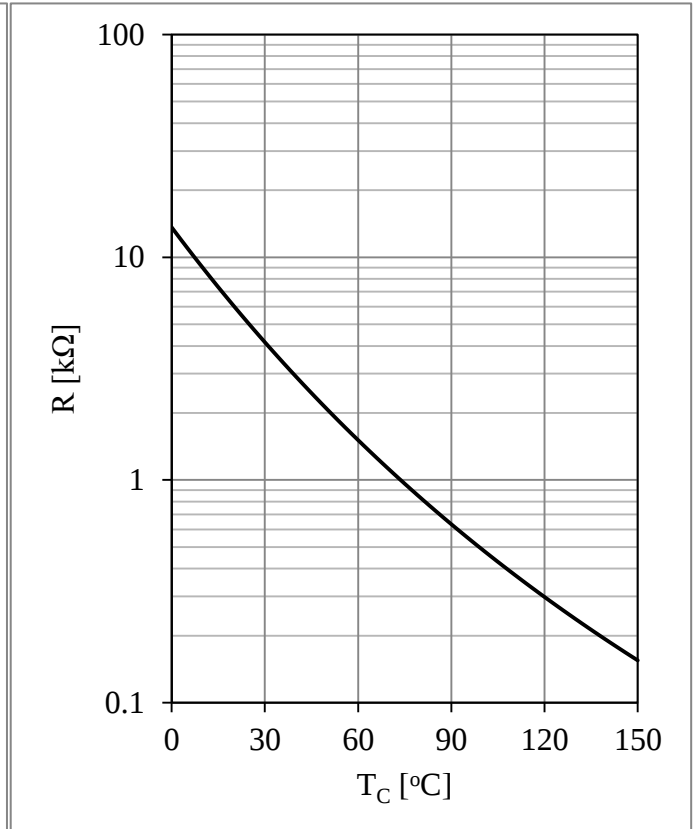
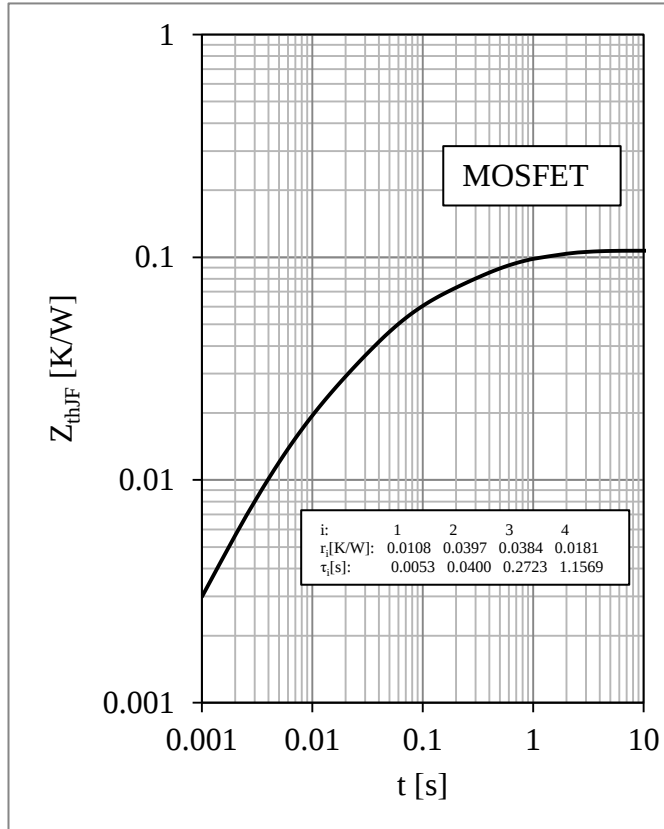
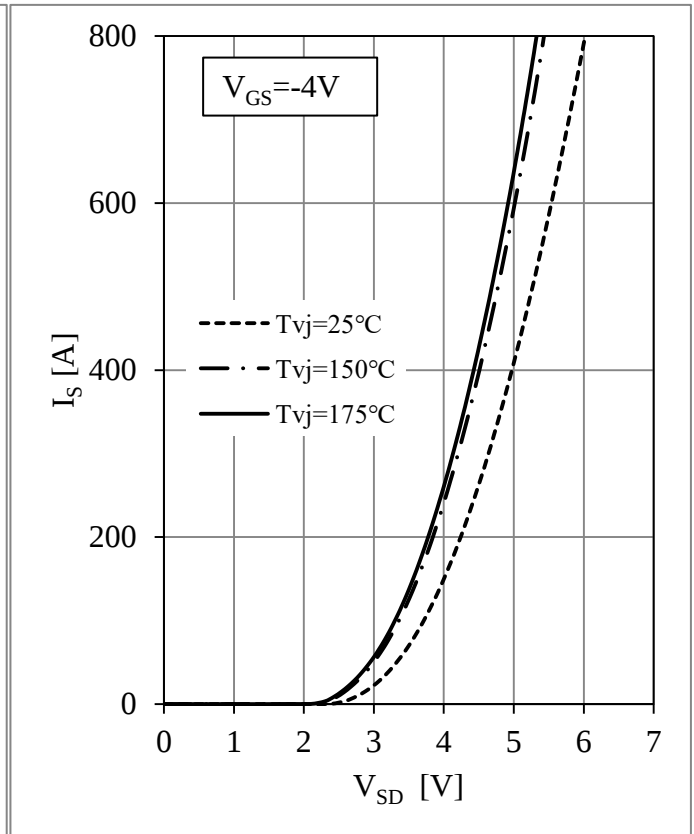
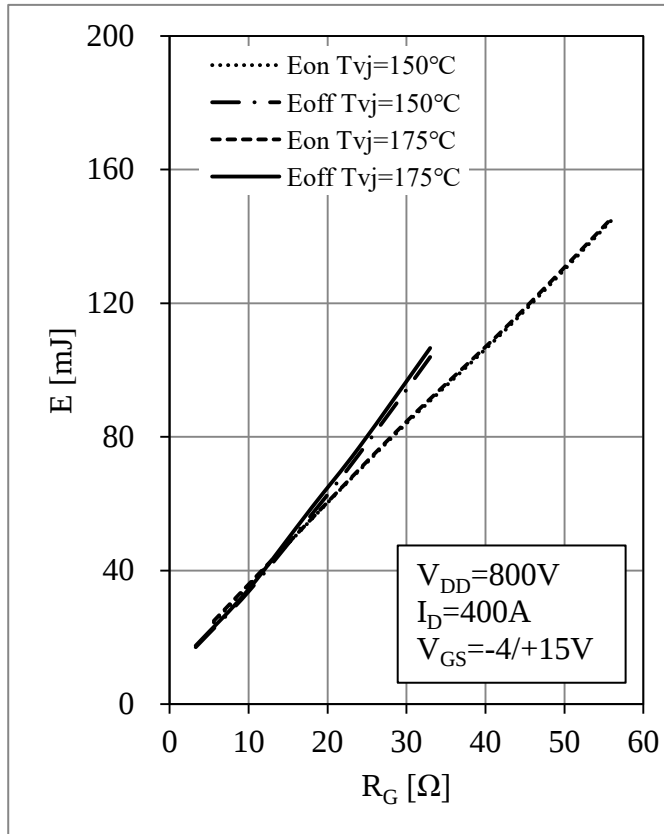
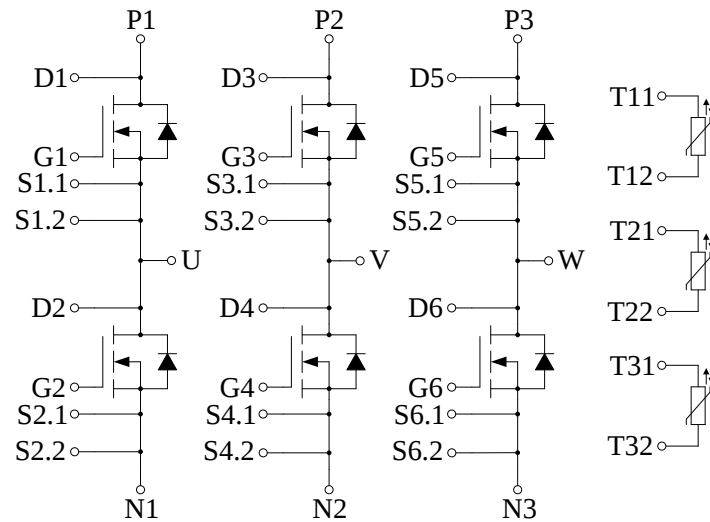


Fig 3. MOSFET Transfer Characteristics

Fig 4. MOSFET Switching Loss vs. I_{DS}

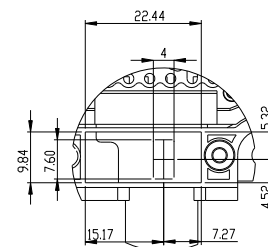
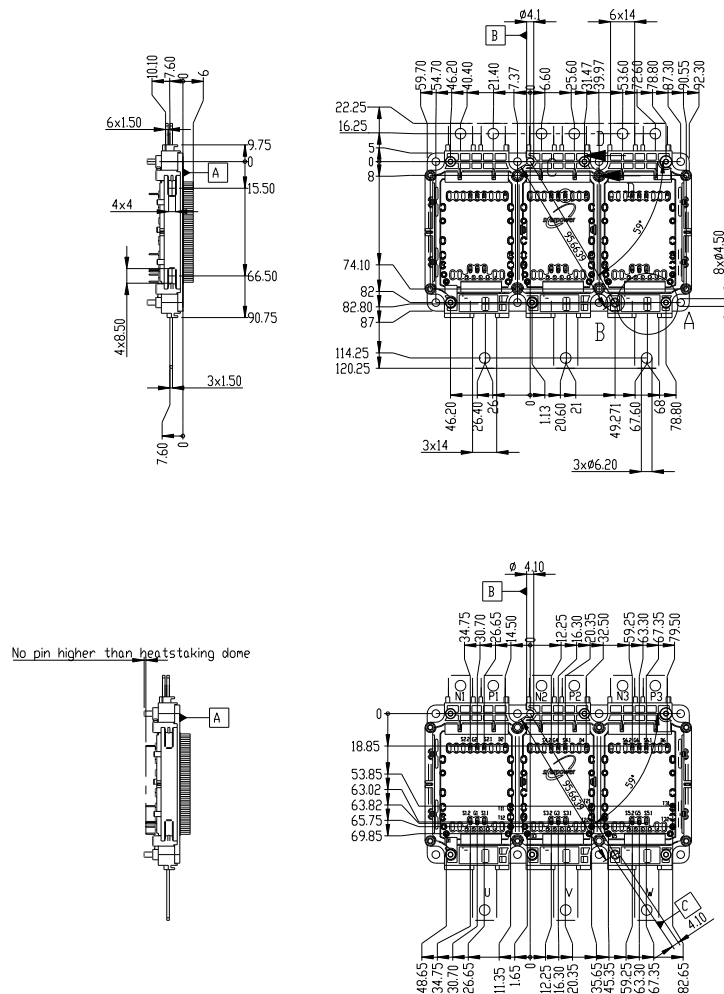


Circuit Schematic

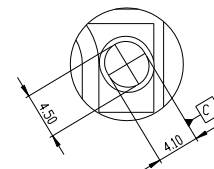


Package Dimensions

Dimensions in Millimeters



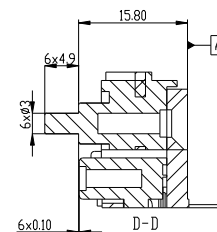
A(1.5:1)



B(3:1)



C(3:1)



比例 2 : 1

All pin positions checked with pin gauge according to Application Note

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